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Application Number	10730382
Filing Date	2003-12-09
First Named Inventor	CHEN
Art Unit	1756
Examiner Name	Angebrannt, Martin J.
Attorney Docket Number	2476-36rwf

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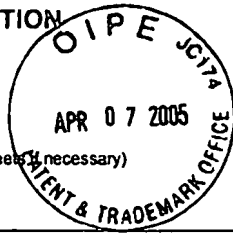
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<i>W</i>	2003/0129545	07/2003	Kik et al.			
<i>W</i>	2003-0117598 A1	06/2003	Case et al.			

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DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

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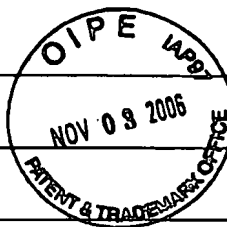
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DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>h</i> WO 03/009058 A2	01/2003	PCT			

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<i>h</i>	Nagase, et al., "Super-Resolution Effect of Semiconductor-Doped Glass," Jpn. J. Appl. Phys. Vol. 38 (1999), pp. 1665-1668, Part 1, No. 3B (03/1999)
<i>u</i>	Noharet, Bertrand, "Harnessing light with semiconductor Spatial Light Modulators," APERTUREN - SURFACES AND IMAGING, Vol. 1-2001, pp. 12-13, XP002363385 (2001)
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